#### Neutron reflectometry at DNS-IV

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#### <u>Outline</u>

- Neutron reflectometers (NR). Basic aspects
- NR at the IBR-2 reactor
- Trends in NR development for pulsed neutron sources
- Requirements for the sample environment
- NR at the future source DNS-IV
- Conclusions



- •Layered nanostructures
- Interlayer magnetic coupling
- Depth magnetization behaviour
- Proximity effects
- •Magnetic field penetration into the superconductive thin films. Magnetic vortex structures
- •Time-resolved domain structures
- Interfaces roughness
- Biological layers
- Magnetic liquids and electrolites
- •Langmuir-Blodgett films

### Two types of measurements



# Vertical and horizontal NR



# NR with horizontal sample positioning

Title	Source	Country	Source type	Set-up type	Polarized neutrons	Flux at sample	q-interval	Minimal reflectivity
REFSANS	FRM II	Germany	SS	TOF	POL	~10 <sup>6</sup> cm <sup>-2</sup> s <sup>-1</sup>	0.05 - 10 nm <sup>-1</sup>	5x10 <sup>-7</sup>
N-REX	FRM II	Germany	SS	SS	POL	3x10 <sup>6</sup> cm <sup>-2</sup> s <sup>-1</sup>	0.01 - 1.5 nm <sup>-1</sup>	1x10 <sup>-7</sup>
FIGARO	ILL	France	SS	TOF	POL	~10 <sup>8</sup> cm <sup>-2</sup> s <sup>-1</sup>	0.05 - 4 nm <sup>-1</sup>	1×10 <sup>-6</sup>
AMOR	SINQ	Switzerland	SS	TOF	non-POL	1x10 <sup>8</sup> cm <sup>-2</sup> s <sup>-1</sup>	0.01 - 5 nm <sup>-1</sup>	1x10 <sup>-5</sup>
Platypus	OPAL	Australia	SS	TOF	POL	1x10 <sup>9</sup> cm <sup>-2</sup> s <sup>-1</sup>	0.05 - 5 nm <sup>-1</sup>	1x10 <sup>-7</sup>
LR	SNS	USA	Pulsed	TOF	non-POL	1x10 <sup>7</sup> cm <sup>-2</sup> s <sup>-1</sup>	0.01 - 2 nm <sup>-1</sup>	1x10 <sup>-6</sup>
GRAINS	IBR-2	Russia	Pulsed	TOF	POL	2x10 <sup>6</sup> cm <sup>-2</sup> s <sup>-1</sup>	0.05 - 1 nm <sup>-1</sup>	1x10 <sup>-5</sup>
Inter	ISIS	UK	Pulsed	TOF	non-POL	1x10 <sup>7</sup> cm <sup>-2</sup> s <sup>-1</sup>	0.01 - 5 nm <sup>-1</sup>	1x10 <sup>-5</sup>
PolRef	ISIS	UK	Pulsed	TOF	POL	1x10 <sup>7</sup> cm <sup>-2</sup> s <sup>-1</sup>	0.01 - 5 nm <sup>-1</sup>	1x10 <sup>-6</sup>
OffSpec	ISIS	UK	Pulsed	TOF	POL	1x10 <sup>7</sup> cm <sup>-2</sup> s <sup>-1</sup>	0.01 - 5 nm <sup>-1</sup>	First experim.
B16	J-PARC	Japan	Pulsed	TOF	POL	1x10 <sup>7</sup> cm <sup>-2</sup> s <sup>-1</sup>	0.01 - 5 nm <sup>-1</sup>	First experim.
REF	CARR	China	SS	SS	non-POL	~10 <sup>7</sup> cm <sup>-2</sup> s <sup>-1</sup>	0.03 - 0.5 nm <sup>-1</sup>	Under constr.

# **Resolution factor**





# $\delta\lambda/\lambda \sim \tau/L$ ,

#### $\tau$ - pulse width, L- flight path mod-det





#### NR at the IBR-2 reactor.



REMUR 0÷50 • 0÷50 18800 C3 D1 (0÷150)x180 40x100 D2 PSD SF 2 APF SF AZ PR 4200 Ø200 Ø200 10x100 8100 500 4450 9500 20500 200x100mm 26200 4900 29000

0÷160

0÷160

REFLEX





Instrument	Plane of scattering	Polarization	Flux at the sample position	Q-range	λ - range, Å
REMUR	Н	+	3 x10 <sup>5</sup> c <sup>-1</sup> cm <sup>-2</sup>	0.05 – 7 нм <sup>-1</sup>	0.9 ÷ 15
REFLEX	Н	+	10 <sup>5</sup> c <sup>-1</sup> cm <sup>-2</sup>	0.01 – 1.3 нм <sup>-1</sup>	1.4 ÷ 10
GRAINS	V	(+)	2 x10 <sup>6</sup> c <sup>-1</sup> cm <sup>-2</sup>	0.05 – 3 нм <sup>-1</sup>	0.5 ÷ 10

# Background at the IBR-2 reactor



#### Background at the IBR-2 reactor





#### Frame overlap problem

The repetition rate (10 Hz for DNS-IV) and the choice of instrument length defines the wavelength band of the instrument





# Trends in NR development.

ESS. FREIA. Fast Reflectometer for Extended Interfacial Analysis. Fast Kinetic Studies to Reflectometry Hanna Wacklin, Anette Vickery, Hanna Wacklin, ESS Instrument Construction Proposal, 2013



### Trends in NR development.

# HERITAGE project for ESS. Focusing neutron guide and GISANS



S. Mattauch et al. Nuclear Instruments and Methods in Physics Research A 841 (2017) 34–46.

### Sample environment for NR

- Low temperatures
- High temperatures
- Magnetic field
- Thermostat (temperature, humidity, pressure)
- X-Ray option
- MBE in-situ chamber



1.5 ÷ 300 K 300 ÷ 900/1900 K 10 ÷ 15 T

#### **Detectors and DAQ**

#### $PSD \ area \sim 500 \ x \ 500 \ mm^2$

#### Resolution $\sim 2mm \ x \ 2 \ mm$





# **Polarization**



#### **NEPTUN: requirements**

1.	Time-average flux density:	$(0.5 \div 12) \cdot 10^{14}$	$\rightarrow$	$\Phi_0 = 5 \cdot 10^{14} \text{ n/cm}^2/\text{s}$
2.	Half-width of fast neutrons:	(20 ÷ 200) μs	$\rightarrow$	$\Delta t_0 = 200 \ \mu s$
3.	<b>Pulse repetition rate:</b>	(10 ÷ 30) Hz	$\rightarrow$	$\mathbf{v} = 10 \ \mathbf{Hz}$
4.	Moderators (at least three):	<u>VC</u> , C, Th	$\rightarrow$	very cold (~30 K)
5.	Background power:	3.2 %		
6.	Number of beam ports	20 - 32		

	<u>SNS</u>	ESS
1. Time-average flux density:	<b>0.1·10<sup>14</sup></b>	<b>3·10</b> <sup>14</sup>
2. Half-width of fast neutrons:	( <b>20</b> ÷ <b>50</b> ) μs	<b>2860 μs</b>
3. Pulse repetition rate:	<b>60 Hz</b>	14 Hz
4. Time-average power:	<b>1 MW</b>	5 MW
5. Background power:	<1%	<1%
6. Number of beam ports:	22	42

# **Required minimum set of NR at the future DNS-IV neutron source**

No.	Instrument	Main issue	Moderator
1	General purpose Horizontal scattering plane	Various resolution, ∆q/q - 1÷10% polarized neutrons, wide angle analyzer, focusing elements and multi-beam collimation, multi-chopper background suppression Off-specular, GISANS, PSD 0.5 x 0.5 m <sup>2</sup> , extended sample environment ( <u>combinations with other techniques</u> , in-situ studies) Real-Time	30 K
2	Liquid reflectometer Vertical scattering plane	Various resolution, ∆q/q - 1÷10% polarized neutrons, wide angle analyzer, focusing elements and multi-beam collimation, multi-chopper background suppression Off-specular, GISANS, PSD 0.5 x 0.5 m <sup>2</sup> , extended sample environment for hard/liquid samples ( <u>combinations with other techniques</u> , in-situ studies) Real-Time	30 K
3	Reflectometer for methodical studies	Testing of new elements and methodical ideas	

#### **Conclusions**

Basing on the trends in the science development in the world and our own experience one have to make a conclusions:

- Two type of NR are demanded: horizontal and vertical planes scattering
- Multi-beam measurement to avoid excess intensity losses
- Instrument flexibility: wide range of measurement modes and parameters (polarized/unpolarized; focusing/collimation ets.)
- > In-situ sample characterization and control
- **>** Real-time measurements
- Wide spectrum of sample environment equipment
- Background suppression at the pulsed reactor demands a special approach
- There are competitive reflectometers can be realized at the future source DNS-IV by the set of basic parameters: intensity, resolution, Q-range.

# Thank you for your attention

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